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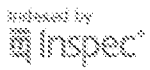| IEEE/IET | Books | Educational Courses | Application Notes [Beta] |

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☐ 2. **Optimisation of microprocessor-based random PWM schemes for power inverters with low switching frequencies**
Hui, S.Y.R.; Sathiakumar, I.;
Applied Power Electronics Conference and Exposition, 1996. APEC '96. Conference Proceedings 1996., Eleventh Annual
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☐ 3. **Prediction control for a cycloconverter of a power distortion compensation system**
Takahashi, I.; Nunokawa, M.;
Industry Applications, IEEE Transactions on
Volume 25, Issue 2, March-April 1989 Page(s):348 - 355
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Velazco, R.; Bellon, C.; Martinet, B.;
Test Conference, 1990. Proceedings., International
10-14 Sept. 1990 Page(s):1012 - 1017
Digital Object Identifier 10.1109/TEST.1990.114124
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Kahrs, M.;
Micro, IEEE
Volume 13, Issue 4, Aug. 1993 Page(s):49 - 51
Digital Object Identifier 10.1109/40.229715

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6. **Speed versus Accuracy Trade-Offs in Microarchitectural Simulations**
Yi, J.J.; Sendag, R.; Lilja, D.J.; Hawkins, D.M.;
Computers, IEEE Transactions on
Volume 56, Issue 11, Nov. 2007 Page(s):1549 - 1563
Digital Object Identifier 10.1109/TC.2007.70744

AbstractPlus | Full Text: PDF(5766 KB)   IEEE JNL
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7. **The SYNARGOS ambient noise measurement buoy**
Burke, S.; Buck, B.; Luther, C.;
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Volume 14, Sep 1982 Page(s):626 - 631

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8. **DPA Using Phase-Based Waveform Matching against Random-Delay Countermeasure**
Nagashima, S.; Homma, N.; Imai, Y.; Aoki, T.; Satoh, A.;
Circuits and Systems, 2007. ISCAS 2007. IEEE International Symposium on
27-30 May 2007 Page(s):1807 - 1810
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Di Santo, M.; Frattolillo, F.; Iannello, G.;
Parallel and Distributed Processing, 1995. Proceedings. Euromicro Workshop on
25-27 Jan. 1995 Page(s):130 - 137
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Alaqeeli, A.; Starzyk, J.;
System Theory, 2001. Proceedings of the 33rd Southeastern Symposium on
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Digital Object Identifier 10.1109/SSST.2001.918517

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11. **Comparison and Impact of Substrate Noise Generated by Clocked and Clockless Digital Circuitry**
Le, J.; Hanken, C.; Held, M.; Hagedorm, M.; Mayaram, K.; Fiez, T.S.;
Conference 2006. IEEE Custom Integrated Circuits
10-13 Sept. 2006 Page(s):105 - 108
Digital Object Identifier 10.1109/CICC.2006.321003

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